UNIVERSITY OF MUMBAI No.UG / 231 of 2008

WILAR:

Areference is invited to the Ordinanes, Regulations and syllabi relating to the A reference of Engineering degree course vide this office Circular No. UG/347 of dated are hereby informed that the recommendation dated 1/ are hereby informed that the recommendation made by the Faculty of at its meeting held on 26th March, 2008 has been accepted by the Faculty of Council at its meeting held on 15th April 2009 Council at its meeting held on 15th April, 2008 has been accepted by the accordance therewith, the Scheme of Examination and syllabi for the Second (Seni III & IV) leading to the B.E. degree course for the Electronics Engineering Appendix and that the same has been brought into force with effect the academic year 2008 - 2009.

VBAI-400 032 June, 2008

The Principals of the affiliated colleges in Engineering.

*437/*15.4.2008

IG231-A of 2008,

MUMBAI-400 032

10th June, 2008

Copy forwarded with compliments for information to :-

The Dean, Faculty of Technology, 1)

The Chairman, Ad-hoc Board of Studies in a in Electronics Engineering 2)

The Controller of Examinations,

The Co-Ordinator, University Computerization Centre, 3)

Board of College and University Development, the Deputy Registrar (Eligibility and Migration Section), the Vice-Chancellor, the Vice-Ch Students Welfare, the Executive Secretary to the Vice-Chancellor, the Pro-Vice-Chancellor, the Assistant Reciptor (2 copies), Record Section Record Section Assistant Registrar, Administrative sub-center, Ratnagiri for information.

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UNIVERSITY OF MUMBAI



Revised Syllabus and Scheme of Examination

> For The Second Year (Sem.III & IV) of the

B.E. Degree Course in Electronics Engineering

(With effect from the academic year 2008-2009)

University of Mumbai

Revised Syllabus of Electronics Engineering June 2008

Semester III

	Mathematics	L	P	TU	TH	TW	PR	OR	TOTAL
1.	Engineering Mathematics	4		1	100	25			125
1	Rusic of Electronic Circuits	4	2		100	25	<i>5</i> 0	25	-
-	Digital System Design I	4	2		100				200
3.	Electrical Network Analysis and	4	2		100	25	50	25	200
4.	Synthesis	4	2		100	25			125
	Control System	4	2		100	25		0.5	
J					100	23		25	150
6.	Presentation and Communication Techniques	2		02		50			50
_		22	08	03	500	175	100	75	850

Semester IV

		L	P	TU	TH	TW	PR	OR	TOTAL
1.	Advanced Engineering Mathematics	4			100				100
2.	Electronic Circuit Analysis and Design	4	2		100	25	50	25	200
3.	Digital System Design II	4	2		100	25	50	25	200
4.	Basics of Analog and Digital Communication Systems	4	2		100	25		25	150
	Electronic and Electrical Measuring Instruments and Machine	4	2		100	25		25	150
6.	Electronic Workshop-I		4			25		25	50
		20	12		500	125	100	125	850

S.E. ELECTRONICS - SEMESTER -III ENGINEERING MATHEMATICS

	Lecture		1
week	Practical		
eriod per week	Tutorial		
		Hours	Marks
	Theory Examination	3	100
aluation System	Practical		
Milate	Oral Examination		
	Term Work		25
	TOTAL		125

	Detailed Gyllabus	Lectures/Week
1	Laplace Transform 1.1 Existence of Laplace Transform, Properties of L.T,1 st and 2 nd shifting theorem, Change of scale Properties, Unit step function, Heavi side, Dirac delta and Periodic function and their L.T 1.2 Inverse L. T. with partial fraction and Convolution theorem	06
	1.3 Applications to solve initial and boundary value problems involving O.D.E.	05
	0.5.5.	02
2	Fourier series Dirichlet's conditions, Fourier series of periodic function with period 2π and $2l$.F.S for even and odd functions. Half range sine and cosine and Parseval's identity.	07
3	3.1 Complex form of Fourier series 3.2.Forier integral and Fourier Transform with properties in detail	02 03
4	Matrices 4.1 Types of matrices, Adjoint, inverse and rank of a matrix. Normal form of a matrix 4.2. System of Homogeneous and non homogeneous equations and their consistency.	06

Z-transform & vector analysis 1. Properties, change of scale, shifting, inverse of z 1. Transform. 1. Transf	Complex variables 5.1. Analytic function-R equation function by Milne-Thompson refunction by Milne-Thompson Reputation by Milne-Thompson Reputation formal mapping, Biline 5.2. Conformal mapping, Biline	on in Cartesian and polar form. Analytic 06 nethod, Harmonic function. ear mapping and standard transforms.	
6.1 Propertion transform. transform. vial value and final value.	- 1 (7)K:		
transition value and final value.		, shifting, inverse of z	
167 the integration scalar potential words 1	transite value and final val	ue.	
6.2 Vector integration, scalar potential work down Greens theorem, Divergence theorem, strokes theorem (without proof).	0.2 Mactor integration, scalar	potential work down Greens at	

prory Examination: Question paper will comprise of total 7 questions, each of 20 marks. Only 5 questions need to be solved.

Only 3 question I will be compulsory and based on entire syllabus.

Question 1 min Questions will be mixed in nature (for example Q2 a) from 2.1 then b) will be from 4.1

or 5.1 other than 2.1.

or 5.1 outer and of each chapter will be proportional to number of respective lecture hours mentioned in the syllabus.

Recommended Books:

- P.N.Wartikar/J.N Wartikar, Text book Applied Mathematics, Vol.1 & II, Pune Vidyarthi Griha Prakashan
- Matrices by Shantinarayan
- Vector Analysis by Murray R. Stiegel, Shaum series
- Higher Engg. Mathematics. Dr. B.S. Grewal,
- Khanna Publication
- Higher Engg. Mathematics by B.V. Ramana
 - Tata Mcgraw-Hill Publishing company Limited.
- 6 Advanced Engg. Mathematics by C.Ray wylie & Louis, C. Barrott
- Tata Mcgraw-Hill Publishing company Limited
- 1 Advanced Engg. Mathematics 8th Ed Erwin kreysizg.
 - John Wiley & Sons, Inc.

S.E. (ELECTRONICS) SEMESTER III BASIC OF ELECTRONIC CIRCUITS

Lecture Practica			
Tutorial			2
	Examination	Hours	Marks
Cystem Practica		3	100
oral Exa	amination	3	50 25
Term W			25
TOTAL			200

Detailed Syllabus	Lectures/Week
Semiconductor Materials and Diodes Review of Semiconductor Materials and Properties, The PN Junction. Review of Semiconductor Diode Theory. Diode Circuits: DC Analysis Introduction to Semiconductor Diode Theory. Diode Circuits: DC Analysis and Models. AC Equivalent Circuits, Other Diode Types – Solar Cell. Photodiode, Light-Emitting Diode, Schottky Barrier Diode, Pin Diode, Zener Diode, Zener as voltage Regulator, Temperature Effects, Understanding Manufacturer's Specifications.	06
Diode Circuits Design of Rectifier Circuits.:- Full Wave Rectification with 'C', 'L-C' & 'pi' Filter, Ripple-Voltage and Diode Current, Voltage Doubler & Multipliesr Circuit, Zener Diode Circuits, Clipper and Clamper Circuits, Multiple-Diode Circuits. Photodiode and LED Circuits.	08
The Bipolar Junction Transistor Basic Bipolar Junction Transistor, PNP &NPN Transistor Structures Device Symbols:, Current-Voltage Characteristics, Transistor Biasing - Single Base Resistor Biasing, Voltage Divider Biasing and Bias Stability, DC Analysis of Transistor Circuits in Common Emitter Common Base and Common Collector configurations, Forward-active Mode Operation Load Line considerations, Non ideal Transistor Leakage Currents and Breakdown. Integrated Circuit Biasing, Multistage Circuits. Transistor Applications - As a Switch,	08
Basic BJT Amplifiers The BJT Linear Amplifier, Graphical Analysis and AC Equivalent Circuit. Small Signal Hybrid – π, (gm rπ) Equivalent Circuit of the Bipolar Transistor, Hybrid – π (gm rπ) Equivalent Circuit Including the Early Effect, Expanded Hybrid – π Equivalent Circuit, Other Small – Signal Parameters And Equivalent Circuits, Basic Transistor Amplifier Configurations i.e. Common Emitter Common Base and Common Collector (Emitter Follower. AC Load Line Analysis, The Three Basic Amplifier configurations: Summary and Comparison, Design of Single Stage BJT Amplifier. Multistage Amplifiers, Band-Width and Power Considerations, Thermal	12

Considerations in Transistor Amplifiers, Manufacturers' Specifications.	3 . 184 ye 1. Gas
The Field Effect Transistor, MOS Field-Effect Transistor, MOSFET, Junction Field-Effect Transistor, MOS Field-Effect Transistor, MOSFET, Junction Field-Effect Transistor, MOSFET, Biasing Mid-Point Biasing, Biasing for Zero Drain Current-Drift Self Biasing Divider Biasing and DC Circuit Analysis, Basic MOSFET Potential Divider Biasing and DC Circuit Analysis, Basic MOSFET Applications: Switch, Digital Logic Gate and Amplifier. Temperature effects Applications: Input Protection in MOSFET. The Power FET (VMOS).	12
Basic FET Amplifiers Basic JFET Amplifier Configurations: Common Source Amplifier, The Source Follower (Common Drain) Amplifier, The Common Gate Configurations. Summary of the Three Basic Amplifier Configurations. According analyses of Common Source Amplifier, The Source Circuit analyses of Common Source Amplifier, The Common Gate Amplifier Follower (Common Drain) Amplifier, The Common Gate Amplifier Configurations. Design of Single Stage JFET Amplifier. MOSFET amplifier Configurations. Design of Single Stage JFET Amplifier. Single – Stage Integrated Circuit MOSFET Amplifiers, Multistage amplifier. Single – Stage Integrated Circuit MOSFET Amplifiers, Multistage Amplifiers.	e r

fest Books.

Donald A. Neamen, Electronic Circuit Analysis and Design, Second edition, McGraw text Books:

Hill International

Robert L Boylestad Louis Nashelsky, Electronic Devices and Circuit theory, sixth

edition, Pentice Lay India. Martin Roden, Gordon Carpenter, William Wieserman, Electronic Design, Fourth

edition, Shroff Publishers,

4 Microelectronics Circuits (Analysis and Design), By Mohammad Rashid, Cengage Learning

Reference Books:

L. Electronics Devices and circuits Theodre F. Bogart, Jr. Jeffrey S. Beasley, Guillermo Rico. 2 Donald Schilling & Charles Belove, Electronic Circuits Discrete and Integrated, Third edition, McGraw Hill

The termwork shall consist of atleast six laboratory experiments covering the whole of syllabus, duly recorded and graded as well as atleast four computer simulations using EDA tools like PSPICE duly recorded and graded. This will carry a weightage of lifteen marks. A test shall be conducted and will carry a weightage of ten marks.

SUGGESTED LIST OF EXPERIMENTS

Laboratory / Simulation

- I. Application of diodes as a (positive / negative and both), a clamper (positive /negative)
- 2. FWR with different types of Filters and finding its ripple factor.
- ^{3.} Voltage Regulation using Zener diode.

s of BJT Amplifier with fixed bias, Collector bias, Potential divider bias.

DC operating point

acteristic of BJT in CB,CC,CE configuration and its parameters.

plifier. Determination of its performance parameters (AV,Ai,Ri,Ro)

plifier and determination of its performance parameters.

S.E. (ELECTRONICS) SEMESTER III DIGITAL SYSTEMS DESIGN I

	Lecture	
week	Practical	1
sind per week	Tutorial	2
P. Commercial Commerci		
	Theory Examination Hours	Marks
- System	Practical 3	100
abation System	Oral Examination 3	50
1	Term Work	25
	TOTAL	25
		200

Detailed Syllabus	Lectures/Week
Introduction and Digital Codes: Analog Vs Digital Systems Digital Devices, Binary codes, Gray codes, Character codes. Codes for detecting and correcting errors	06
Logic Circuits: Boolean Algebra, theorems, combinational circuit analysis, combinational circuit synthesis, minimization, Karnaugh Map, Sum of Products, Product of Sums form, and their minimization, Programmed minimization-Quine Mc-Cluskey minimization algorithm, timing hazards-Static, Dynamic Hazards	14
Combinational MSI, LSI Devices: Combinational design using SSI, MSI devices, Decoders (74x139,74x138), Encoders (74x148). Tri state buffers (74x244.74x245), Multiplexers (74x151), Parity circuits(74180), Comparators(7485), Adders (7483), Subtractors, BCD adders - subtractors, ALU (74181), Combinational Multipliers, Combinational PLDs	10
Logic families: Basics of TTL, CMOS, ECL Circuits for basic logic operations just Circuits and working of them in all above families. No Characteristics of families.	10
Sequential Logic Practices: Basic Elements, Latches and Flip flops, S-R, D.T, J-K latches and Flip flops, Flip Flop conversions, Applications of Latches and Flip-Flop in switch debouncing, bus holder circuits, Flip-flop Timing Considerations and Metastability.	08
Counters - Asynchronous, Synchronous counters, Up down counters, Mod counters, Ring counters. Shift Registers, Universal Shift register.	08

Work shall consist of at least eight laboratory experiments covering the whole of syllabus, duly work shall carry a weightage of fifteen marks. A test shall be conducted and will and graded of ten marks. Work shall consist of at least eight laboratory experiments covering the whole of syllabus, duly work shall be conducted and will carry and graded. This will carry a weightage of fifteen marks. A test shall be conducted and will carry and graded of ten marks.

SUGGESTED LIST OF EXPERIMENTAL SUGGESTED SUGGESTED LIST OF EXPERIMENTAL SUGGESTED Andrew of ten marks.

peexperiments must include: Verification of basic gates (1 Experiment) Verification of basic services / parity generators / adders / Subtractors etc using gates or MSI

Applications (2 Experiments)

Applications (2 Experiments) Applies (2 Experiments) devices (2 Experiments)

Use of Decoders, Encoders, Multiplexers (2 Experiments)

Use of Conversion (1 Experiment)

Use of Conversion (1 Experiment) Flop Convenience of Synchronous / Asynchronous counters, Shift Registers (2 Experiments)
Applications

RP Jain: Modern Digital Design, forth edition, Tata McGraw Hill.

1. Morris Mano, Digital Design, Pearson Education Asia 2005 RP Jann. Digital Design, Pearson Education, 1 ata McGraw Morris Mano, Digital Design, Pearson Education, Asia, 2002

John F. Wakerley, Digital Design Principles and Practices, third edition updated. Pearson 1. Education. Singapore, 2002. geference Books

Education, Digital Logic : Applications and Design, Thomson Brooks Cole . 2004 John M. Yarbrough, Digital Logic : Applications and Design, Thomson Brooks Cole . 2004

S.E. (ELECTRONICS) SEMESTER III

ELECTRICAL NETWORK ANALYSIS AND SYNTHESIS

peck	ractical	04	1
week P	utorial	0.	2
	Theory Examination	Hours	Marks
cystem	Practical	3	100
(Oral Examination	•••	
	Term Work	***	
	TOTAL	***	25
			125

	Detailed Syllabus	Lectures/Week
	Circuit analysis (ac and de): Kirchoff's law, Loop variable analysis, Node variable analysis, Source transformations, Reference directions for current and voltage, Active element conventions, dot convention for coupled circuits. Linearity, Superposition, Thevenin's and Norton's, Maximum power for ac source and dependent source.	12
	Linear graphs: Introductory definitions, The incidence matrix A, the loop matrix B, relationship between sub matrix of A and B. Cut-sets and cut-set matrix, Fundamental cut-sets and fundamental tie-sets, Planar graphs, A and B matrices, Loop, node, node pair equations, duality.	08
	Laplace transforms: Properties of Laplace transforms, basic theorems, Laplace transform of gate function, impulse function and periodic functions, convolution integral, inverse Laplace transform, application of Laplace transforms to solution of Network problems.	08
	Transient and frequency analysis: Transient response of R-L, R-C, R-L-C circuits (Series combinations only) for d.c. and sinusoidal excitations – Initial conditions - Solution using differential equation approach and Laplace transform methods of solutions Transfer function. Concept of poles and zeros. Concept of frequency	•
	Two port networks: Concept of two port networks, Driving point and Transfer functions., open circuit and short circuit parameters, transmission and inverse transmission parameters, hybrid parameters, inter-relationship of different parameters, interconnection of two port networks, T and pi representation, terminated two port networks.	
6.	Fundamentals of network synthesis: Realizability concept, Hurwitz property, positive realness, properties positive real functions, testing positive real functions, Synthesis of R-L C and L-C driving point functions – Foster and Cauer forms.	of R-

jisthooks:

Franklin F. Kuo, "Network analysis and synthesis", PHI.

Franklin F. Nav, Franklin F. Nav, M. E. Vanvalkenberg, "Network analysis", PHI, third edition. M. E. Hayt and Jack Kemmerly, "Engineering Circuit

M. E. Vanvalkenders, "Engineering Circuit analysis", TMH.

3. Property Books:
Circuits and Networks - Analysis and Synthesis: A. Sudhakar and S.P. Shyam
Mohan.

Mohan.

D. Roy Choudhury: Networks and Systems, New Age International Pubs.

termwork shall consist of at least four experiments and four assignments covering the whole syllabus, remwork share ded. This will carry a weightage of fifteen marks. A test shall be conducted and will a weightage of ten marks. aweightage of ten marks.

SUGGESTED LIST OF EXPERIMENTS

- Verification of superposition theorem using ac/dc source.
- Verification of Thevenin's theorem using dependent/independent source.
- Verification of maximum power transfer theorem using ac/dc source.
- Verification of source transformation.
- 5. Charging and discharging of a capacitor.
- 6. Measurement of h parameters.

S.E. (ELECTRONICS) SEMESTER III

CONTROL SYSTEM ENGINEERING

	Lecture		
ak .	Practical	0	1
Jar week	Tutorial	0:	2
	A SHE SHELL AND		•
	Theory Examination	Hours	Marks
ion System	Practical	3	100
011 3	Oral Examination	2	
/	Term Work		25
	TOTAL		25
			150

Detailed Syllabus	Lectures/Week
Introduction to control system analysis Introduction. examples of control systems, open loop control systems, closed loop control systems. Transfer function. Types of feed back & feed back control system characteristics noise rejection, gain, sensitivity, stability.	06
Mathematical modeling of systems Importance of a mathematical model, Block diagrams, signal flow graphs, Masan's gain formula and its application to block diagram reduction. State space method, solving time-invariant system, transfer matrix.	(16)
Transient & steady state - Response Analysis 3.1 Impulse response function, First order system, second order system, time domain specifications of systems, analysis of transient-response using Second order model. 3.2 Classification of control systems according to "Type" of systems. Steady - state errors, static error constants, Steady - state analysis of different types of systems using step, ramp and parabolic input signals.	12
Stability Analysis Introduction to concept of stability, Stability analysis using Routh's stability criterion, Absolute stability, Relative stability. Root-Locus plots, summary of general rules for constructing Root-Locus, Root-Locus analysis of control systems. Compensation techniques-Log, lead, log-lead.	09
Frequency-Response Analysis Introduction, Frequency domain specifications, resonance peak and peak resonating frequency, relationship between time and frequency domain specification of systems. Bode plots, Polar plots, Log-magnitude Vs phase plots, Nyquist stability criterion, stability analysis, Relative stability, gain margin, phase margin, stability analysis of system using Bode plots Closed-Loop Frequency Response-Constant gain and phase loc Nichol's chart and their use in stability study of systems.	

Control components & Controller Control compositions, servoamplifier, potientiometer, synchro transmitters, AC servo receivers, synchro control transformer stem 09 AC servointeners, synchro control transformer, stepper motors, synchro controller modes, continuous controller modes, synchro recentional de de la controller modes, continuous controller modes, composite piscontinuous controller modes, composite de la controller modes, composite modes, controller modes, controller modes, controller modes, composite modes, controller mod controllers.

forthooks:
Nagrath, M Gopal, Control system Engineering, Tata McGraw Hill Nagrath, Modern Control Engineering, Pearson education, 11 Nagrath, Modern Control Engineering, Pearson education, third edition, N. Ogata, Modern C. Kuo, Automatic Control Systems, Pearson education, the edition, paniamin C. Kuo, Automatic Control Systems, Pearson education, K. Ogata, Modern C. Kuo, Automatic Control Systems, Pearson education, seventh edition.

Reference Books.

Reference Bo Mise, control system Engineering, John wiley & sons, 3rd edition Nise, control systems of the Curtis Johnson, Process Control Instrumentation Technology, Pearson education, fourth edition.

The Termwork shall consist of at least ten experiments and three assignments based on the whole syliabus. the recorded and graded. This will carry a weightage of fifteen marks. A test shall be conducted and will any a weightage of ten marks.

SUGGESTED LIST OF EXPERIMENTS

Laboratory / Simulations

- 1. Transient response of 1st order & 2nd order system
- 2. Frequency response of 1st order & 2nd order system
- 3. Steady state error analysis of different types of systems
- 4. D.C. servomotor
- 5. A.C. servomotor
- 6. Synchro Transmitter and Receiver
- 7. Potentiometer

Simulation

- 1. Block diagram reduction
- 2. Time response analysis
- 3. Frequency response analysis
- 4. Stability analysis

S.E. (ELECTRONICS) SEMESTER III PRESENTATION AND COMMUNICATION TECHNIQUES

nweek	Lecture	12		
period per week	Practical			
	Tutorial			
	- world	2	2	
	Theory	Hours	Marks	
Evaluation System	Theory Examination			
Flam	Practical			
	Oral Examination			
	Term Work		50	
	Total		50	

Detailed Syllabus	Lectures/Week
Internal and external communication, Types of meetings, strategies for conducting successful business meetings, documentation (notice, agenda, minutes, resolution) of meetings. Introduction to modern communication techniques (e-mail, internet, video-conferencing, etc.) Legal and ethical issues in communication (Intellectual property rights: patents, TRIPS, Geographical indications)	06
Advanced technical writing: Report writing: Definition and importance of reports, qualities of reports, language and style in reports, types of reports, formats (letter, memo, project-repots). Methods of compiling data for preparing report. A computer-aided presentation of a technical project report based on survey-based or reference based topic. The topics are to be assigned to a group of 8-10 students. The written report should not exceed 20 printed pages. Technical paper-writing Writing business proposals.	08
Interpersonal skills: Introduction to emotional intelligence, motivation, Negotiation and conflict resolution, Assertiveness, team-building, decision-making, time-management, persuasion	03.
Presentation skills: Elements of an effective presentation, Structure of a presentation, Presentation tools, Audience analysis, Language: Articulation, Good pronunciation, Voice quality, Modulation, Accent and Intonation.	04

(,	Career skills: Career skills: Preparing resumes and cover letters. Types of Resumes, Interview techniques: preparing for job interviews, facing an interview, verbal and non-verbal preparing during interviews, observation sessions and role-play communication during interviews to be used to demonstrate interview strategies (mock interviews)	04
	Group discussion: group discussions as part of selection process. Structure of a group discussion, process of group behavior, techniques for effective participation, Team work and use of body language	03

ferm work:

Assignments:

1255ignments on communication topics

jassignments on report-writing

jassignments on interpersonal skills

2assignments on career skills

M least one class test (written)

Distribution of term work marks will be as follows:

Assignments: 10 marks Written test: 10 marks

Project report presentation: 20 marks

Group discussion: 10 marks

Books recommended:

1. Fred Luthans: Organizational behavior, McGraw Hill

2 Lesikar and Petit, Report writing for business, Tata McGraw Hill

3. Huckin & Olsen, Technical writing and professional communication,

McGraw Hill

4 Wallace & Masters, Personal development for Life & work, Thomson

Meta Murphy, Effective Business Communication, McGraw Hill

6. Raman and Sharma, Report writing.

Additional Readings

Lewicki, Saunders & Minton: Essentials of negotiation, McGraw Hill

2. Hartman Lemay, Presentation Success, Thomson Learning

3 Kitty O. Locker, Stephen Kyo Kaczmarek: Business Communication,

Building Critical skills, McGraw Hill

Vikas Gupta: COMPDEX Computer Course kit, IDG Books Pvt. Ltd.

Heller & Handle, The Essential Manager's manual, Dorling Kindersley

6. The Sunday times "Creating Success Series" 1. Develop your dssertiveness 2. Make every minute count 3. Successful Presentation

skills 4. How to motivate people? 5. Team building Daniel Goleman, Emotional Intelligence.

S.E. (ELECTRONICS) SEMESTER IV

ADVANCED ENGINEERING MATHEMATICS

al	Lecture	4	
wried per week	Practical		
Tr.	Tutorial		
·		Hours	Marks
Cystem	Theory Examination	3	100
Faluation System	Practical		
	Oral Examination		
	Term Work		
	Total		100

 Detailed Syllabus	Lectures/Week
Random variables: 1.1 Discrete and continuous random variable, Probability	02
mass and density function for random variables. 1.2 Expected value, Variance, Moments and moment generating functions	03
1.3 Relation between Raw and central moments.	02
Probability distributions: 21. Binomial, Poisson and Normal distribution	06
22.Introduction to distribution such as 't' and ' χ^2 ',central limit theorems and problems based on this theorem.	04
 Sampling theory: 3.1 Large and small samples, Test of significance for both samples.	05
3.2 paired 't' test 3.3 Application for χ^2 distribution	01 02
Discrete Structure 4.1 Relation and function (Equivalence relation, Injective, surjective and bijective functions)	04
4.2. Poset, Lattice(Bounded, complemented and distributive lattice) 4.3. Algebraic structure: Group, Ring, Field	04
	04
Matrices 5.1. Cayley Hamilton theorem,	04
eigen values and eigen vectors (without proof) 5.2. Similar matrices, orthogonally similar matrices, reduction to the diagonal form.	04

Complex variables 6.1 Cauchy's theorem and Cauchy's integral formula 6.2 Taylor's and Laurent's formula, Singularities and poles. 6.3 Residue theorem.	03 04 03

two Examination: Examination.

Evamination.

Overstion paper will comprise of total 7 questions, each of 20 marks.

Overstion paper will comprise of total 7 questions, each of 20 marks. 1. Questions need to be solved.

Only 3 question 1 will be compulsory and based on entire syllabus.

3. Opening questions will be mixed in patural 6.

Remaining questions will be mixed in nature (for example Q2 a) from 2.1 then b) will be from 4.1 or 5.1 other than 2.1.

In question paper weightage of each chapter will be proportional to number of respective lecture hours mentioned in the syllabus.

recommended Books:

PN. Wartikar/J. N Wartikar, Text book Applied Mathematics, Pune Vidyarthi Griha

Theory of complex variable by Shantinarayan

Engineering Mathematics by S.S.Sastri

Fundamental of Mathematicals Statistics By S.C.Gupta and V.K Kapoor

Probability and Statistics Schum series

Discrete Mathematics By Kolman, Busby, Sharon Rus

Function of discrete Mathematics by K.D.Joshi

S.E. (ELECTRONICS) SEMESTER IV

ELECTRONIC CIRCUITS ANALYSIS AND DESIGN

period per week	Lecture	1	
period per	Practical Tutorial	2	
Evaluation System	Theory Examination Practical Oral Examination	Hours 3 3	Marks 100 50
	Term Work Total		25 25 200

	Detailed Syllabus	Lectures/Week
Frequency Response of Amplifiers High frequency parameters of BJT.Amplifier Frequency Response, System Transfer Functions, S – Domain Analysis, First – Order Functions, Bode Plots, Short-Circuit and Open-Circuit Time Constants, high Frequency Response of BJT, FET and MOSFET amplifier analysis.		09
2	OSCILLATORS- Analysis and Design of phase shift, Quadrature, Wien bridge, Hartley, Colpitt and Crystal Oscillator.	09
3	Power Amplifiers Power Amplifiers, Power Transistors – Power BJTs, Power MOSFETs, , Design of Class- A, Class- AB Push Pull Class- B Transformer Coupled Push Pull Amplifier, Complementary Class B Power Amplifier. Heat Sinks, Design of heat sinks, for power Amplifier Devices	09
4	Differential Amplifiers BJT, FET & MOSFET Differential Amplifier Analysis and Design, Design of CMOS, Differential Amplifier with Active Load (Ref:- Donald Neamen).	09
5.	Multistage Amplifiers Design Two Stage BJT, JFET and MOSFET Amplifiers and Design of CASCODE Amplifiers. Design of BJT-JFET hybrid amplifier.	12
6.	Feedback and Stability Feedback Concepts, Ideal Close-Loop Gain, Gain Sensitivity Bandwidth Feedback Concepts, Ideal Close-Loop Gain, Gain Sensitivity Bandwidth Extension, Noise Sensitivity, Reduction of Nonlinear Distortion, Ideal Extension, Noise Sensitivity, Reduction	08

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Learning
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Hill International Carpenter, William Wieserman, Electronic Design, Fourth

Reference Books:

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Adel Sedra & Kenneth Smith, Microelectronic Circuits, Fourth edition, Oxford

Termwork:

The term work shall consist of atleast six laboratory experiments covering the whole of syllabus, duly the term work and graded as well as at-least four computer simulations using EDA tools like PSPICE duly neorded and graded. This will carry a weightage of fifteen marks. A test shall be conducted and will carry

SUGGESTED LIST OF EXPERIMENTS

Laboratory / Simulations

- I. To Study frequency Response of Cascode Amplifier
- 2. To study RC phase shift Oscillator and Calculate threshold & practical
- 3. To Study Current Series negative feedback amplifier and plot gain with feedback & without feedback.
- 4. To study Wein Bridge Oscillator
- 5. To study Class AB and B Pushpull Amplifier.
- 6. To study Hartley Oscillator. Calculate theoretical & practical frequency.
- 7. To study Colpitts Oscillator. Calculate theoretical & practical frequency.
- 8. To study frequency response of two stage RC coupled Amplifier.

S.E. (ELECTRONICS) SEMESTER IV

glectronic and Electrical Measuring Instruments and Machine

wack	Lecture		
period per week	Practical	4	
	Tutorial	2	
	The second secon		
cystem	Theory Examination	Hours	Marks
valuation System	Practical	3	100
	Oral Examination		
	Term Work		25
	Total		25
			150

Detailed Syllabus	Lectures/Week
Electronic and Digital Voltmeters: Principles of operation, advantages over conventional type analog voltmeters, basic voltmeter, peak reading, average reading true RMS reading, sampling type, FET voltmeters, sensitivity considerations & calculations. Methods of analog-to-digital and digital-to-analog conversion, principles of operation and typical specifications of a digital voltmeter, description of various types of DVMs with block diagrams, Resolution and Sensitivity of a digital meter, digital displays for meters.	08
Frequency meters, phase meters and signal generators: Analog-schematic & operational details, limitations. Digital Frequency meters, Phase measurement by voltage addition method, balanced modulation type, phase meters using flip-flops, digital meters, advantages & limitations of each type. Requirement of a good laboratory type signal generator, A.F. signal generators, Beat frequency oscillator & its advantages.	09
Block diagram study of C.R.O., Description of panel layout & implementation of controls. Requirement of time base, triggered time base, delayed time base, external triggering etc. Lissajous patterns, use of these in phase & frequency measurements. Frequency time base, Wobbler scope & its applications, Dual trace, multi trace, Double beam. Sampling: Storage, Digital read-out oscilloscopes. Use of CRO in square wave testing of amplifiers, tracing of diode & transistor characteristics.	09
Basic measuring instruments: Essentials of indicating instruments – deflecting, controlling and damping torque. Construction and working principles of moving iron and moving coil ammeters and voltmeters, electrodynamometer watt-meters, induction type energy meters, power factor meters, instrument transformers.	12
Measurement of R, L and C: Measurement of low, medium, high resistances: Ohmmeter, Kelvin's double bridge, Wheatstone's bridge, Measurement of inductance: Maxwell's, Hay's and Anderson's bridge. Measurement of capacitance: Schering bridge.	08

6.1 DC Motors: Back e.m.f., voltage equation, characteristics of series, shunt and compound motors, torque equations, speed control of dc shunt/series motors, three point and four point starter and applications of dc motors.	04
6.2 Three phase induction motors: Construction and principle of operation, slip, rotor frequency, torque equation, torque-speed characteristics, starting methods of induction motors.	03
6.3 Stepper motors: Construction, working principle and applications of variable reluctance, permanent magnet and hybrid stepper motors.	03

Text books:

- 1) Cooper W. D. & Helfrick A.D., Electronics Instrumentation & Measurement Techniques, third edition Prentice Hall of India, 1985
- Kalsi H.S., Electronic Instrumentation, first edition, Tata McGraw Hill, 1997.
- 3) Electrical and electronic measuring instruments: A.K.Sawhney.

Reference Books;

- 1) Electrical Measurements and measuring instruments: Golding and Widdis.
- 2) Electric Machines: Nagrath and Kothari.

Termwork:

The Termwork shall consist of at least eight experiments and three assignments covering the whole syllabus, duly recorded and graded. This will carry a weightage of fifteen marks. A test shall be conducted and will carry a weightage of ten marks.

SUGGESTED LIST OF EXPERIMENTS

- 1 Study of dual integrating DVM.
- 2 a) Measurement of frequency using intensity modulation.
 - b) Design and implementation of digital phase meter.
 - c) Design and implementation of digital frequency meter.
- 3 a) Measurement of frequency using Lissajous patterns.
 - b) Measurement of phase difference using X Y mode of CRO.
 - c) Application of CRO for component testing.
- ⁴ a) Calibration of single phase energy meter.
 - b) Conversion of galvanometer into ammeter voltmeter.
- a) Measurement of unknown resistance using Kelvin's double bridge. 5
 - b) Measurement of unknown capacitance using Schering's bridge.
 - c) Measurement of unknown inductance using Anderson's bridge.
- 6 a) Speed control of dc shunt motor using armature and field control.
 - b) Starting of three phase induction motor using auto transformer starter.

S.E. (ELECTRONICS) SEMESTER IV

BASIC OF ANALOG AND DIGITAL COMMUNICATION SYSTEM

week	Lecture	4		
period per week	Practical 2			
	Tutorial			
		Hours	Marks	
Evaluation System	Theory Examination	3	100	
	Practical			
	Oral Examination		25	
	Term Work		25	
	Total	ineri e Julia i.	150	

_	Detailed Syllabus	Lectures/Week
	Elements of Communication System: Basic block diagram of communication system, Modulation and Demodulation concept, channels Noise in Communication System, Signal-to-Noise ratio, noise factor and Noise Figure, equivalent Noise Temperature Electromagnetic Waves Propagation: Propagation terms and Definitions.	06
	Amplitude Modulation: Principles of DSB Full Carrier AM. envelope detector, practical diode detector. Different types of AM: DSB-SC, SSB-SC, VSB, ISB	12
	Angle modulation Principles of Frequency Modulation and Phase Modulation. FM Modulators, types of FM: NBFM and WBFM, FM Transmitter, noise triangle, pre-emphasis and de-emphasis circuits. FM Detection: frequency discriminator and phase discriminator	12
	Radio Receivers Receiver Characteristics, TRF Receivers, and Super heterodyne Receivers: choice of IF, AGC, AFC In AM and FM receivers.	07
-	Analog Pulse Modulation Sampling Theorem for Low pass signals, Aliasing error, Sampling Sampling Theorem for Low pass signals, Aliasing error, Sampling Sampling Theorem for Low pass signals, Aliasing error, Sampling Sampling Theorem for Low pass signals, Aliasing error, Sampling Sampling Theorem for Low pass signals, Aliasing error, Sampling Sampling Theorem for Low pass signals, Aliasing error, Sampling Sampling Theorem for Low pass signals, Aliasing error, Sampling Sampling Theorem for Low pass signals, Aliasing error, Sampling Sampling Theorem for Low pass signals, Aliasing error, Sampling Sampling Theorem for Low pass signals, Aliasing error, Sampling Sampling Theorem for Low pass signals, Aliasing error, Sampling Sampling Theorem for Low pass signals, Aliasing error, Sampling Sampling Theorem for Low pass signals, Aliasing error, Sampling Sampling Theorem for Low pass signals, Aliasing error, Sampling Sampling Theorem for Low pass signals, Aliasing error, Sampling Sampling Theorem for Low pass signals, Aliasing error, Sampling Sampling Theorem for Low pass signals, Aliasing error, Sampling Sampling Theorem for Low pass signals, Aliasing error, Sampling the Sampling	07

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Text Books:

Text Books (Electronics communication system) Pearson education, Third edition

Kennedy and Davis "Electronics communication system", Tata Mcgraw Hill

R.P. Sing and S.D. Sapre, "Communication systems Analog and Digital", Tata Mcgraw Hill

4. Taub and schilling "principles of communication systems", Tata Mcgraw Hill

Reference Books:

- Roy Black, "Electronics communication system", Cengage learning, second edition.
- 1. B.P. Lathi "Modern Digital and analog Communication system" Thired edition, OXFORD
- 3. Robert J. Schoenbeck "Electronics communications modulation and transmission".
- Lean W couch "Digital and Analog communication system", Pearson education, Sixth edition.

Term Work:

The term work shall consists of at least eight Laboratory experiments covering the whole of syllabus, duly recorded and graded. This will carry a weightage of fifteen marks. A test shall be conducted and will carry a weightage of ten marks.

SUGGESTED LIST OF EXPERIMENTS

- I. Amplitude Modulation And Demodulation
- 2. DSB-SC & SSB-SC Modulation ,demodulation
- 3. Frequency Modulation and Demodulation
- 4. Study of Superhetrodyne Receiver characteristics
- 5. Sampling and Reconstruction of sampled signals
- 6. Pulse Modulation (PAM, PWM, PPM)
- 7. Delta Modulation
- 8. Time Division Multiplexing of PCM signals
- 9. Line codes (NRZ, RZ, AMI-RZ)
- 10. Simulation on AM.FM / Multiplexing

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S.E. (ELECTRONICS) SEMESTER IV

Electronics Workshop-I

period per week	Practical	4	
	Tutorial		
	The	Hours	Marks
valuation System	Theory Examination Practical		
	Oral Examination		25
	Term Work		25
	Total		50

Detailed Syllabus

This syllabus is designed to encourage students to design and implement innovative ideas. The syllabus will give them in depth practical knowledge from design to the final verification stage. Documentation of any project is an important part of the project and students are expected to document their work properly in standard IEEE format.

Every group of students should select different projects. Number of students should not be less than TWO and not more than THREE in one group.

1. Study of Soldering Techniques and PCB Design

Students are expected to select any experiment* that they have already performed in earlier semester. Soldering and testing is to be done for the selected experiment. Perform simulation of the same experiment by using CAD tools. Schematic as well as PCB design is to be carried out using CAD tools.

2. Design, Simulation and Implementation of Analog Project

Students are expected to design any* analog application of their choice. Perform simulation using software tools. PCB design, fabrication of PCB, testing and implementation should be done. Documentation of the project is to be done preferably in standard IEEE format using Latex/WinTex. Project report should include abstract in maximum 100 words, keywords, introduction, design, simulation, implementation, results, conclusion and references.

Students are expected to design any* digital application of their choice. Perform simulation 3. Digital Project using software tools for hardware description. Design should be synthesized using FPGA/CPLD. Documentation of the project is to be done preferably in standard IEEE format using Latex/WinTex. Project report should include abstract in maximum 100 words, keywords, introduction, design, simulation, implementation, results, conclusion and references.

1. Roberts G. W. and Sedra A.S., "SPICE". 2nd ed, USA References:-

- 2. Rashid M.H. "SPICE for circuits and electronics using pSpice", Prentice Hall

^{*} To be approved by the subject Teacher

Tuinenger P.W., "SPICE: A Guide to circuit simulation and analysis using pSpice", Prentice Hall Bosshart, "Printed Circuit Boards: Design and Technology", Tata McGraw Hill Orcad/PCBII, "User's Guide". www.xilinx.com

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